


<b>Search Notes</b> 	<b>Application/Control No.</b> 10507066	<b>Applicant(s)/Patent Under Reexamination</b> YE, SHEN
	<b>Examiner</b> Benny Lee	<b>Art Unit</b> 2817

SEARCHED			
Class	Subclass	Date	Examiner
333	99S, 204, 219	23 January 2008	BTL
505	210, 866	25 January 2008	BTL
Researched above		9/12/08	BTL

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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